## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | AIZAWA, TAKASHI | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,327,387	02-2008	Tanaka et al. 348/207.99	
*	В	US-2004/0109062	06-2004	Yamaya, Kunihiko	348/207.1
*	С	US-7,304,667	12-2007	Watanabe et al.	348/221.1
*	D	US-2004/0114044	06-2004	McCurdy et al.	348/207.99
*	Е	US-2002/0090208	07-2002	HATANAKA, KOJI	386/117
*	F	US-6,954,280	10-2005	Kaibara, Hiroshi	358/1.15
*	G	US-6,937,356	08-2005	Ito et al.	358/1.16
*	Н	US-6,930,709	08-2005	Creamer et al.	348/211.3
*	ı	US-6,889,364	05-2005	Camara et al.	715/771
	J	US-			
	K	US-	1		
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
6	R					
	s					
	Т				100	

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.